

Notice of References Cited	Application/Control No. 10/067,658	Applicant(s)/Patent Under Reexamination BEAN ET AL.	
	Examiner Kelly L. Jerabek	Art Unit 2612	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,630,950	10-2003	Ohkawara et al.	348/208.12
	C	US-6,710,809	03-2004	Niikawa, Masahito	348/372
	D	US-6,795,642	09-2004	Matsumoto et al.	386/109
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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